Issue Classification

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Application/Control No.	Applicant(s)/Patent Under Reexamination
10005936	MASUYAMA ET AL.
Examiner	Art Unit
TSE CHEN	2116

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	CLASS		(SUBCLASS					С	LAIMED			N	ON-	CLAIMED
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	CR	OSS REF	ERENCE(S)											
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NONE		Total Claims All	lowed:
(Assistant Examiner) (Date)		24	
/TSE CHEN/	6/12/08	O.G. Print Claim(s)	O.G. Print Figure
(Primary Examiner)	(Date)	1	3